

IGBT - Power, Co-PAK N-Channel, Field Stop VII (FS7), SCR, TO247-3L

1200 V, 1.5 V, 60 A

FGHL60T120RWD

Description

Using the novel field stop 7th generation IGBT technology and the Gen7 Diode in TO247 3-lead package, FGHL60T120RWD offers the optimum performance with low conduction losses and good switching controllability for a high efficiency operation in various applications like motor control, UPS, data center and high-power switch.

Features

- Low Conduction Loss and Optimized Switching
- Maximum Junction Temperature $T_J = 175$ °C
- Positive Temperature Coefficient for Easy Parallel Operation
- High Current Capability
- 100% of the Parts are Dynamically Tested
- Short Circuit Rated
- RoHS Compliant

Applications

- Motor Control
- UPS
- General Application Requiring High Power Switch

MAXIMUM RATINGS (T_{.I} = 25°C unless otherwise noted)

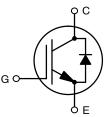
Param	Symbol	Value	Unit	
Collector-to-Emitter Voltage		V _{CES}	1200	V
Gate-to-Emitter Voltage		V _{GES}	±20	
Transient Gate-to-Emitte	er Voltage	1	±30	
Collector Current	T _C = 25°C (Note 1)	Ic	120	Α
	T _C = 100°C	1	60	
Power Dissipation	T _C = 25°C	P _D	833	W
	T _C = 100°C		416	
Pulsed Collector Current	T _C = 25°C (Note 2) t _p = 10 μs	I _{CM}	180	Α
Diode Forward	T _C = 25°C (Note 1)	I _F	120	
Current	T _C = 100°C	1	60	
Pulsed Diode Maximum Forward Current	$T_{C} = 25^{\circ}C,$ $t_{p} = 10 \mu s$	I _{FM}	180	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +175	°C
Lead Temperature for Soldering Purposes		TL	260	

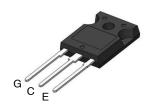
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Value limit by bond wire.
- 2. Repetitive rating: Pulse width limited by max. junction temperature.

BV _{CES}	V _{CE(SAT)}	lc
1200 V	1.5 V	60 A

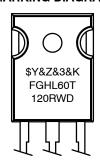
PIN CONNECTIONS





TO-247-3LD CASE 340CX

MARKING DIAGRAM



\$Y = onsemi Logo &Z = Assembly Plant Code &3 = 3-Digit Date Code &K = 2-Digit Lot Traceability Code FGHL60T120RWD = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping
FGHL60T120RWD	TO-247 (Pb-Free)	30 Units / Tube

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THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case for IGBT	$R_{ heta JC}$	0.18	°C/W
Thermal Resistance, Junction-to-Case for Diode	$R_{\theta JCD}$	0.33	
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	40	

ELECTRICAL CHARACTERISTICS OF IGBT (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				•	•
Collector-to-Emitter Breakdown Voltage	BV _{CES}		1200			V
Collector-to-Emitter Breakdown Voltage	ΔBV_CES	$V_{GE} = 0 \text{ V, } I_{C} = 5 \text{ mA}$		1225		mV/°C
Temperature Coefficient	ΔT_{J}					
Zero Gate Voltage Collector Current	I _{CES}	V _{GE} = 0 V, V _{CE} = V _{CES}			40	μΑ
Gate-to-Emitter Leakage Current	I _{GES}	V _{GE} = 20 V, V _{CE} = 0 V			±400	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GE(th)}	$V_{GE} = V_{CE}, I_{C} = 60 \text{ mA}, T_{J} = 25^{\circ}\text{C}$	4.9	5.94	6.7	V
Collector-to-Emitter Saturation Voltage	V _{CE(sat)}	$V_{GE} = 15 \text{ V}, I_{C} = 60 \text{ A}, T_{J} = 25^{\circ}\text{C}$	1.2	1.48	1.8	
		V _{GE} = 15 V, I _C = 60 A, T _J = 175°C		1.81		1
DYNAMIC CHARACTERISTICS						
Input Capacitance	C _{ies}			7128		pF
Output Capacitance	C _{oes}	V _{CE} = 30 V, V _{GE} = 0 V, f = 1 MHz		252]
Reverse Transfer Capacitance	C _{res}	1		25.3]
Total Gate Charge	Qg			256		nC
Gate-to-Emitter Charge	Q _{ge}	$V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V},$ $I_{C} = 60 \text{ A}$		64.1		
Gate-to-Collector Charge	Q _{gc}	10 - 00 /		102		
SWITCHING CHARACTERISTICS						
Turn-on Delay Time	t _{d(on)}			48		ns
Turn-off Delay Time	t _{d(off)}	1		290		
Rise Time	t _r	1		30		
Fall Time	t _f	$V_{CE} = 600 \text{ V}, V_{GE} = 0/15 \text{ V}$ $I_{C} = 30 \text{ A R}_{G} = 4.7 \Omega \text{ T}_{J} = 25^{\circ}\text{C}$		138		
Turn-on Switching Loss	E _{on}			1.9		mJ
Turn-off Switching Loss	E _{off}	1		1.8		7
Total Switching Loss	E _{ts}			3.7		1
Turn-on Delay Time	t _{d(on)}			51		ns
Turn-off Delay Time	t _{d(off)}	1		250		
Rise Time	t _r	V_{CE} = 600 V, V_{GE} = 0/15 V I_{C} = 60 A R _G = 4.7 Ω I_{J} = 25°C		64		
Fall Time	t _f			139		
Turn-on Switching Loss	E _{on}			4.5		mJ
Turn-off Switching Loss	E _{off}]		3.4		
Total Switching Loss	E _{ts}	1		8.0		1

ELECTRICAL CHARACTERISTICS OF IGBT ($T_J = 25^{\circ}C$ unless otherwise noted) (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS	<u>.</u>					
Turn-on Delay Time	t _{d(on)}			45		ns
Turn-off Delay Time	t _{d(off)}			328		
Rise Time	t _r			35		
Fall Time	t _f	$V_{CE} = 600 \text{ V}, V_{GE} = 0/15 \text{ V}$ $I_{C} = 30 \text{ A R}_{G} = 4.7 \Omega \text{ T}_{J} = 175^{\circ}\text{C}$		228		1
Turn-on Switching Loss	E _{on}			3.3		mJ
Turn-off Switching Loss	E _{off}			2.4		
Total Switching Loss	E _{ts}			5.7		
Turn-on Delay Time	t _{d(on)}			52		ns
Turn-off Delay Time	t _{d(off)}			296		1
Rise Time	t _r			68		1
Fall Time	t _f	$V_{CE} = 600 \text{ V}, V_{GE} = 0/15 \text{ V}$ $I_{C} = 60 \text{ A R}_{G} = 4.7 \Omega \text{ T}_{J} = 175^{\circ}\text{C}$		224		
Turn-on Switching Loss	E _{on}	10 = 35 / (11		6.9		mJ
Turn-off Switching Loss	E _{off}			5.1		1
Total Switching Loss	E _{ts}			12.0		
DIODE CHARACTERISTICS	-					-
Forward Voltage	V _F	I _F = 60 A, T _J = 25°C	1.46	1.74	2.08	V
		I _F = 60 A, T _J = 175°C		1.7		1
DIODE SWITCHING CHARACTERISTICS	S, INDUCTIVE LOAD)				
Reverse Recovery Time	t _{rr}			183		ns
Reverse Recovery Charge	Q _{rr}	V _R = 600 V, I _F = 30 A, dI _F /dt = 500 A/μs, T _J = 25°C		1815		nC
Reverse Recovery Energy	E _{REC}			0.5		mJ
Peak Reverse Recovery Current	I _{RRM}			19.9		Α
Reverse Recovery Time	t _{rr}	V _R = 600 V, I _F = 60 A, dI _F /dt = 500 A/μs, T _J = 25°C		257		ns
Reverse Recovery Charge	Q _{rr}			2651		nC
Reverse Recovery Energy	E _{REC}			0.9		mJ
Peak Reverse Recovery Current	I _{RRM}			20.6		Α
Reverse Recovery Time	t _{rr}	V _R = 600 V, I _F = 30 A, dI _F /dt = 500 A/μs, T _J = 175°C		279		ns
Reverse Recovery Charge	Q _{rr}			4008		nC
Reverse Recovery Energy	E _{REC}			1.4		mJ
Peak Reverse Recovery Current	I _{RRM}			28.7		Α
Reverse Recovery Time	t _{rr}			420		ns
		V _D = 600 V I= = 60 Δ		6200		nC
Reverse Recovery Charge	Q_{rr}	V _B = 600 V. I _F = 60 A.		6392		
Reverse Recovery Charge Reverse Recovery Energy	Q _{rr} E _{REC}	$V_R = 600 \text{ V}, I_F = 60 \text{ A},$ $dI_F/dt = 500 \text{ A}/\mu\text{s}, T_J = 175^{\circ}\text{C}$		2.5		mJ

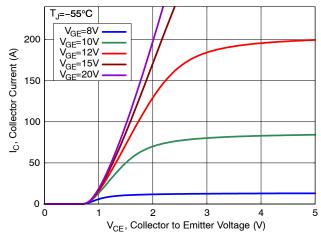
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

200

T_J=25°C

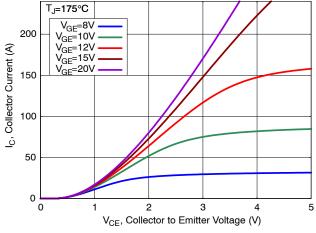
V_{GE}=8V



V_{GE}=10V V_{GE}=12V V_{GE}=15V V_{GE}=20V I_C, Collector Current (A) 150 100 50 0 2 3 5 0 V_{CE}, Collector to Emitter Voltage (V)

Figure 1. Output Characteristics

Figure 2. Output Characteristics



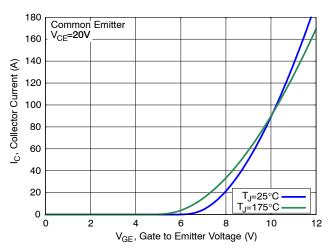
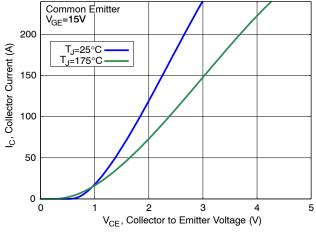


Figure 3. Output Characteristics

Figure 4. Transfer Characteristics



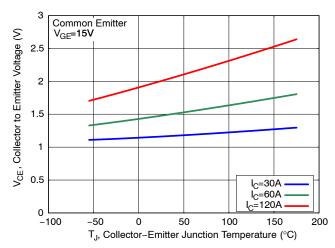


Figure 5. Saturation Characteristics

Figure 6. Saturation Voltage vs. Junction **Temperature**

TYPICAL CHARACTERISTICS

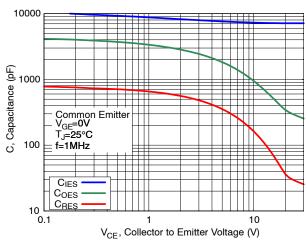


Figure 7. Capacitance Characteristics

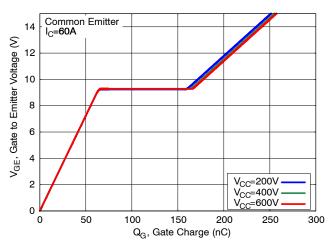


Figure 8. Gate Charge Characteristics

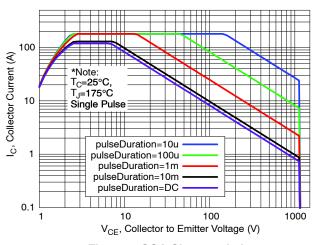


Figure 9. SOA Characteristics

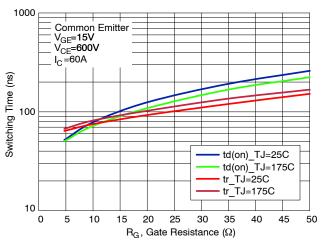


Figure 10. Turn-On Switching Time vs. Gate Resistance

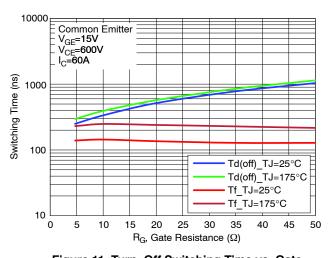


Figure 11. Turn-Off Switching Time vs. Gate Resistance

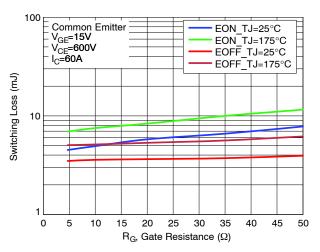


Figure 12. Switching Loss vs. Gate Resistance

TYPICAL CHARACTERISTICS

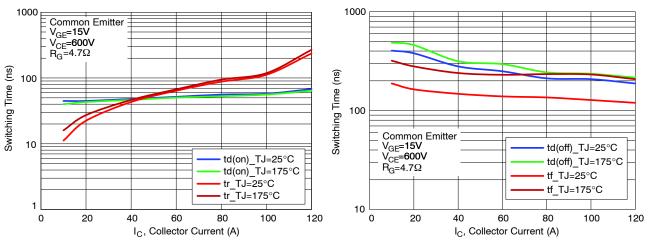


Figure 13. Turn-On Switching Time vs. Collector Current

Figure 14. Turn-Off Switching Time vs. Collector Current

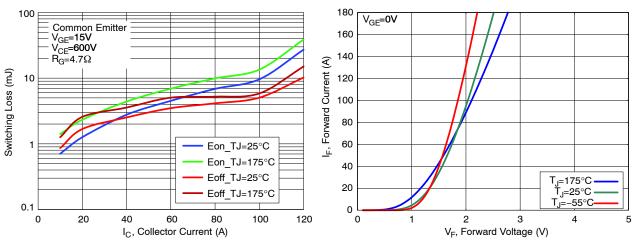


Figure 15. Switching Loss vs. Collector Current

Figure 16. Diode Forward Characteristics

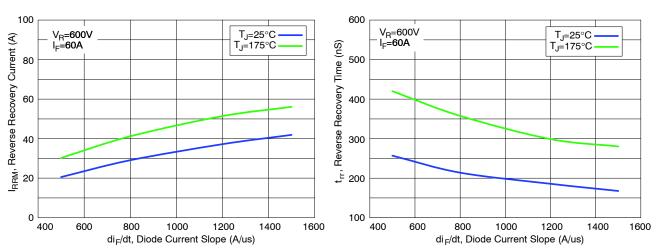


Figure 17. Diode Reverse Recovery Current

Figure 18. Diode Reverse Recovery Time

TYPICAL CHARACTERISTICS

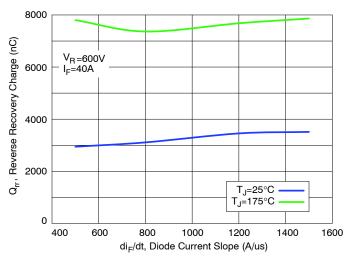


Figure 19. Diode Stored Charge Characteristics

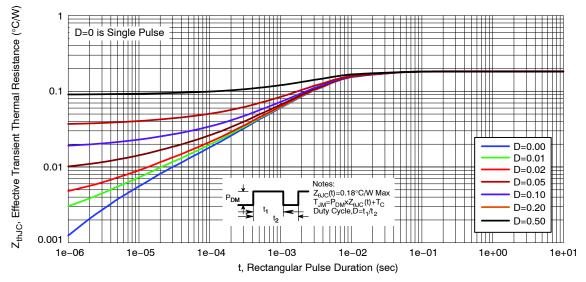


Figure 20. Transient Thermal Impedance of IGBT

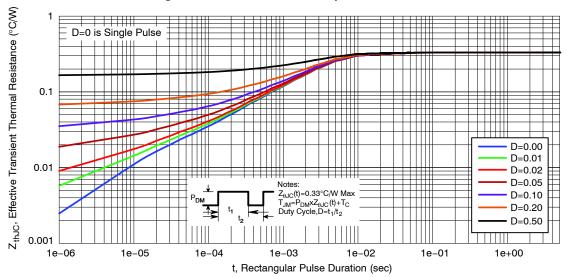
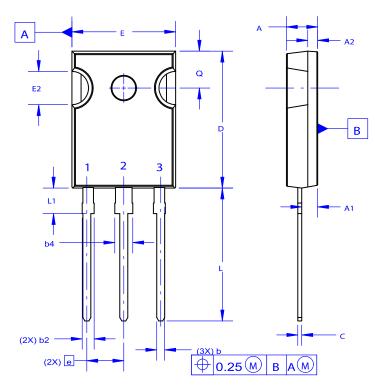


Figure 21. Transient Thermal Impedance of Diode

PACKAGE DIMENSIONS

TO-247-3LD CASE 340CX **ISSUE A**

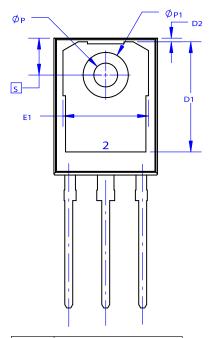


NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

 B. ALL DIMENSIONS ARE IN MILLIMETERS.

- C. DRAWING CONFORMS TO ASME Y14.5 2009.
 D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.



DIM	MIL	LIMETER	S
DIM	MIN	NOM	MAX
Α	4.58	4.70	4.82
A 1	2.20	2.40	2.60
A2	1.40	1.50	1.60
D	20.32	20.57	20.82
Е	15.37	15.62	15.87
E2	4.96	5.08	5.20
е	~	5.56	~
L	19.75	20.00	20.25
L1	3.69	3.81	3.93
ØΡ	3.51	3.58	3.65
Q	5.34	5.46	5.58
S	5.34	5.46	5.58
b	1.17	1.26	1.35
b2	1.53	1.65	1.77
b4	2.42	2.54	2.66
С	0.51	0.61	0.71
D1	13.08	?	~
D2	0.51	0.93	1.35
E1	12.81	~	~
Ø P 1	6.60	6.80	7.00

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